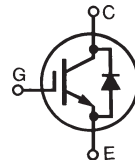


# HiPerFAST™ IGBT with Diode

## C2-Class High Speed IGBTs

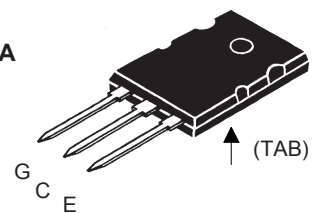
**IXGK 60N60C2D1**  
**IXGX 60N60C2D1**

**V<sub>CES</sub> = 600 V**  
**I<sub>C25</sub> = 75 A**  
**V<sub>CE(sat)</sub> = 2.5 V**  
**t<sub>fi(typ)</sub> = 35 ns**

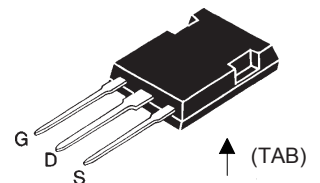


Symbol	Test Conditions	Maximum Ratings	
V <sub>CES</sub>	T <sub>J</sub> = 25°C to 150°C	600	V
V <sub>CGR</sub>	T <sub>J</sub> = 25°C to 150°C; R <sub>GE</sub> = 1 MΩ	600	V
V <sub>GES</sub>	Continuous	±20	V
V <sub>GEM</sub>	Transient	±30	V
I <sub>C25</sub>	T <sub>C</sub> = 25°C (limited by leads)	75	A
I <sub>C110</sub>	T <sub>C</sub> = 110°C	60	A
I <sub>CM</sub>	T <sub>C</sub> = 25°C, 1 ms	300	A
<b>SSOA</b> <b>(RBSOA)</b>	V <sub>GE</sub> = 15 V, T <sub>VJ</sub> = 125°C, R <sub>G</sub> = 10 Ω Clamped inductive load @ V <sub>CE</sub> ≤ 600 V	I <sub>CM</sub> = 100	A
P <sub>C</sub>	T <sub>C</sub> = 25°C	480	W
T <sub>J</sub>		-55 ... +150	°C
T <sub>JM</sub>		150	°C
T <sub>stg</sub>		-55 ... +150	°C
M <sub>d</sub>	Mounting torque, TO-264	1.13/10 Nm/lb.in.	
<b>Weight</b>	TO-264	10	g
	PLUS247	6	g
Maximum lead temperature for soldering 1.6 mm (0.062 in.) from case for 10 s		300	°C

**TO-264 AA  
(IXGK)**



**PLUS247  
(IXGX)**



G = Gate      C = Collector  
E = Emitter    Tab = Collector

### Features

- Very high frequency IGBT and anti-parallel FRED in one package
- Square RBSOA
- High current handling capability
- MOS Gate turn-on for drive simplicity
- Fast Recovery Epitaxial Diode (FRED) with soft recovery and low I<sub>RM</sub>

### Applications

- Switch-mode and resonant-mode power supplies
- Uninterruptible power supplies (UPS)
- DC choppers
- AC motor speed control
- DC servo and robot drives

### Advantages

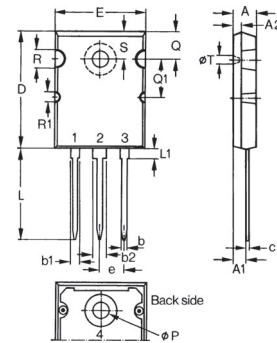
- Space savings (two devices in one package)
- Easy to mount with 1 screw

Symbol	Test Conditions	Characteristic Values (T <sub>J</sub> = 25°C, unless otherwise specified)		
		Min.	Typ.	Max.
V <sub>GE(th)</sub>	I <sub>C</sub> = 250 μA, V <sub>CE</sub> = V <sub>GE</sub>	3.0		5.0 V
I <sub>CES</sub>	V <sub>CE</sub> = V <sub>CES</sub> V <sub>GE</sub> = 0 V			650 μA
				T <sub>J</sub> = 25°C
I <sub>GES</sub>	V <sub>CE</sub> = 0 V, V <sub>GE</sub> = ±20 V			±100 nA
V <sub>CE(sat)</sub>	I <sub>C</sub> = 50 A, V <sub>GE</sub> = 15 V Note 1			T <sub>J</sub> = 25°C
				T <sub>J</sub> = 125°C
				1.8 V

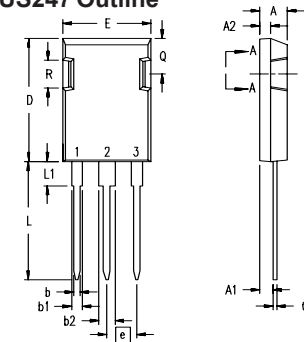
Symbol	Test Conditions	Characteristic Values			
		$(T_J = 25^\circ\text{C}, \text{ unless otherwise specified})$			
		Min.	Typ.	Max.	
$g_{fs}$	$I_C = 50 \text{ A}; V_{CE} = 10 \text{ V},$ Note 1	40	58	S	
$C_{ies}$	$V_{CE} = 25 \text{ V}, V_{GE} = 0 \text{ V}, f = 1 \text{ MHz}$		3900	pF	
$C_{oes}$			280	pF	
$C_{res}$			97	pF	
$Q_g$	$I_C = 50 \text{ A}, V_{GE} = 15 \text{ V}, V_{CE} = 0.5 V_{CES}$		146	nC	
$Q_{ge}$			28	nC	
$Q_{gc}$			50	nC	
$t_{d(on)}$	<b>Inductive load, <math>T_J = 25^\circ\text{C}</math></b> $I_C = 50 \text{ A}, V_{GE} = 15 \text{ V}$ $V_{CE} = 400 \text{ V}, R_G = R_{off} = 2.0 \Omega$		18	ns	
$t_{ri}$			25	ns	
$t_{d(off)}$			95	150	ns
$t_{fi}$			35	ns	
$E_{off}$			0.48	0.8	mJ
$t_{d(on)}$	<b>Inductive load, <math>T_J = 125^\circ\text{C}</math></b> $I_C = 50 \text{ A}, V_{GE} = 15 \text{ V}$ $V_{CE} = 400 \text{ V}, R_G = R_{off} = 2.0 \Omega$		18	ns	
$t_{ri}$			25	ns	
$E_{on}$			0.9	mJ	
$t_{d(off)}$			130	ns	
$t_{fi}$			80	ns	
$E_{off}$		1.2	mJ		
$R_{thJC}$			0.15	0.26	KW
$R_{thCK}$					KW

**Reverse Diode (FRED)**

Symbol	Test Conditions	Characteristic Values			
		$(T_J = 25^\circ\text{C}, \text{ unless otherwise specified})$			
		min.	typ.	max.	
$V_F$	$I_F = 60 \text{ A}, V_{GE} = 0 \text{ V},$ Note 1			2.1	V
				1.4	
		$T_J = 150^\circ\text{C}$			
$I_{RM}$	$I_F = 60 \text{ A}, V_{GE} = 0 \text{ V}, -di_F/dt = 100 \text{ A}/\mu\text{s}$ $V_R = 100 \text{ V}$			8.3	A
$t_{rr}$	$I_F = 1 \text{ A}; -di/dt = 200 \text{ A/ms}; V_R = 30 \text{ V}$		35		ns
$R_{thJC}$				0.85	KW

 Note 1: Pulse test,  $t \leq 300 \mu\text{s}$ , duty cycle  $\leq 2\%$ 
**TO-264 AA Outline**


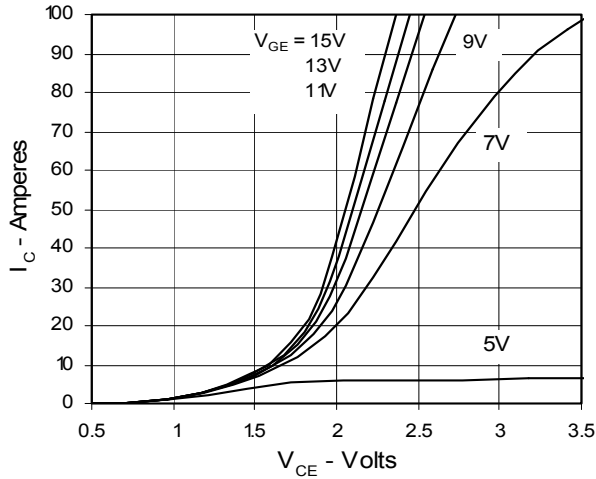
Dim.	Millimeter		Inches	
	Min.	Max.	Min.	Max.
A	4.82	5.13	.190	.202
A1	2.54	2.89	.100	.114
A2	2.00	2.10	.079	.083
b	1.12	1.42	.044	.056
b1	2.39	2.69	.094	.106
b2	2.90	3.09	.114	.122
c	0.53	0.83	.021	.033
D	25.91	26.16	1.020	1.030
E	19.81	19.96	.780	.786
e	5.46BSC		.215BSC	
J	0.00	0.25	.000	.010
K	0.00	0.25	.000	.010
L	20.32	20.83	.800	.820
L1	2.29	2.59	.090	.102
P	3.17	3.66	.125	.144
Q	6.07	6.27	.239	.247
Q1	8.38	8.69	.330	.342
R	3.81	4.32	.150	.170
R1	1.78	2.29	.070	.090
S	6.04	6.30	.238	.248
T	1.57	1.83	.062	.072

**PLUS247 Outline**

 Terminals: 1 - Gate  
 2 - Drain (Collector)  
 3 - Source (Emitter)  
 4 - Drain (Collector)

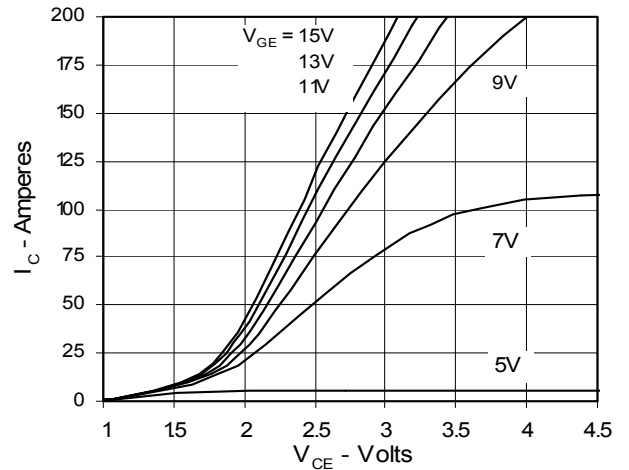
Dim.	Millimeter		Inches	
	Min.	Max.	Min.	Max.
A	4.83	5.21	.190	.205
A <sub>1</sub>	2.29	2.54	.090	.100
A <sub>2</sub>	1.91	2.16	.075	.085
b	1.14	1.40	.045	.055
b <sub>1</sub>	1.91	2.13	.075	.084
b <sub>2</sub>	2.92	3.12	.115	.123
C	0.61	0.80	.024	.031
D	20.80	21.34	.819	.840
E	15.75	16.13	.620	.635
e	5.45 BSC		.215 BSC	
L	19.81	20.32	.780	.800
L1	3.81	4.32	.150	.170
Q	5.59	6.20	.220	0.244
R	4.32	4.83	.170	.190

IXYS reserves the right to change limits, test conditions, and dimensions.

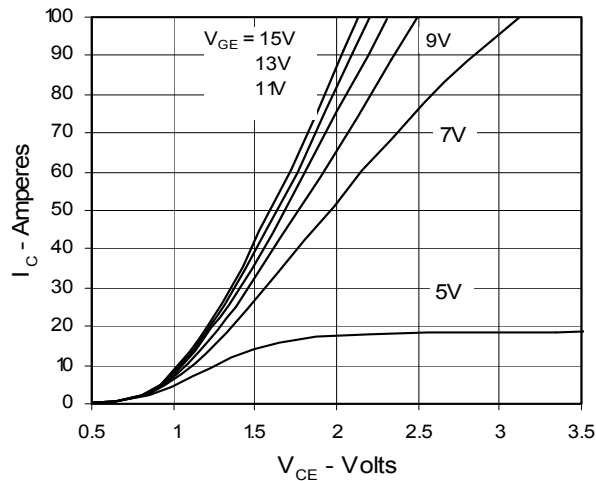
**Fig. 1. Output Characteristics**  
**@ 25 Deg. C**



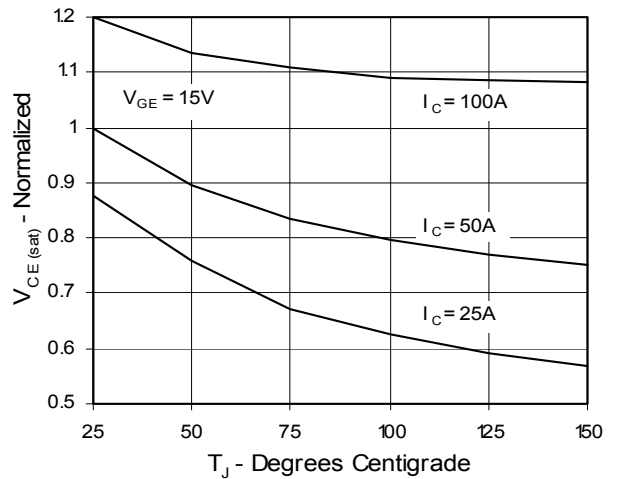
**Fig. 2. Extended Output Characteristics**  
**@ 25 deg. C**



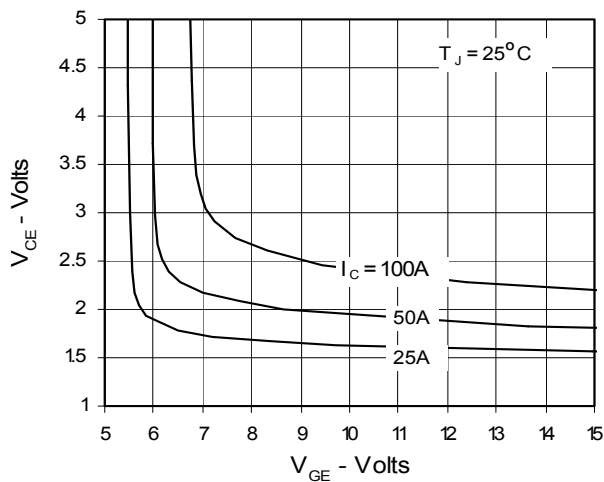
**Fig. 3. Output Characteristics**  
**@ 125 Deg. C**



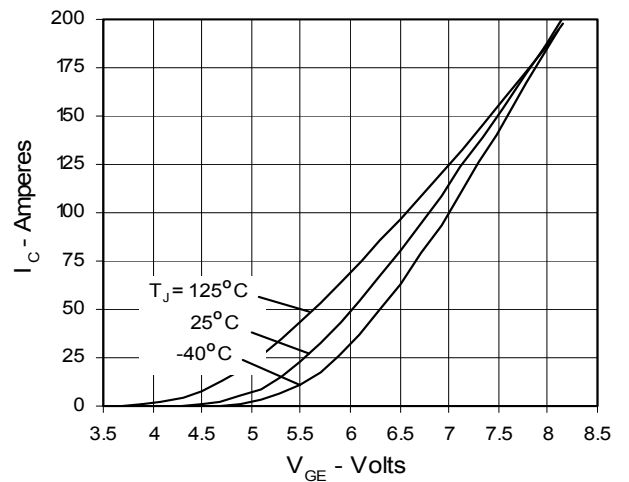
**Fig. 4. Temperature Dependence of  $V_{CE(sat)}$**



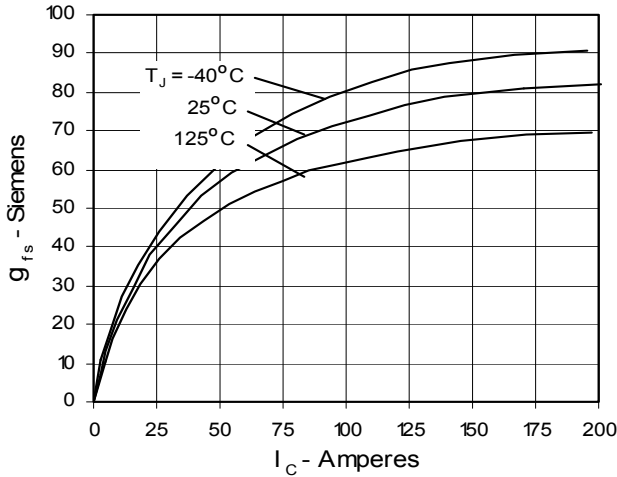
**Fig. 5. Collector-to-Emitter Voltage vs. Gate-to-Emitter voltage**



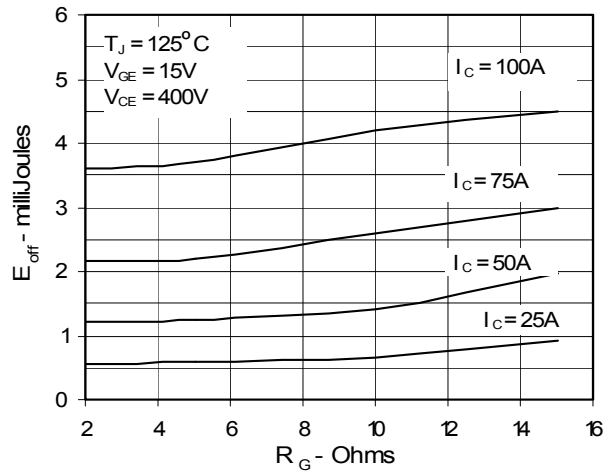
**Fig. 6. Input Admittance**



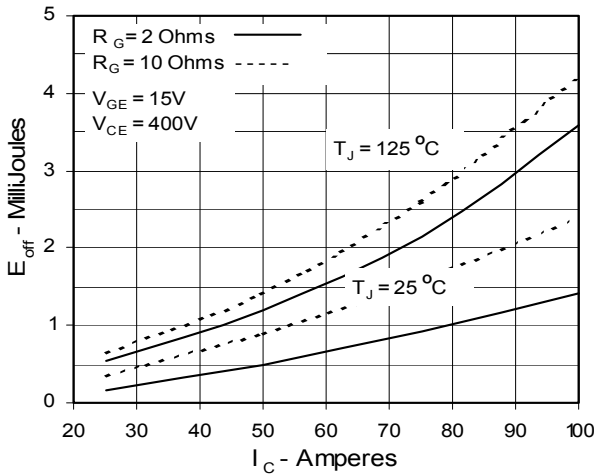
**Fig. 7. Transconductance**



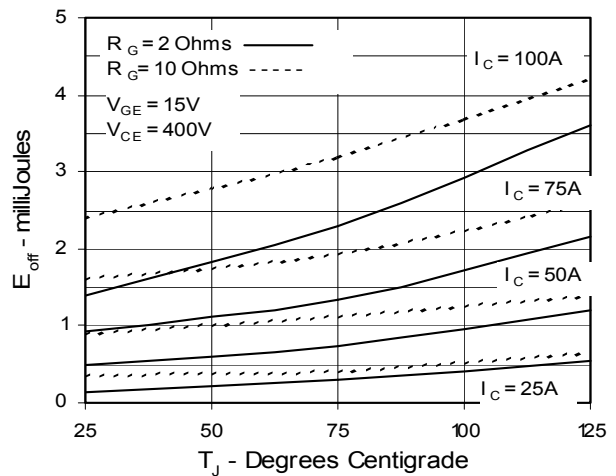
**Fig. 8. Dependence of  $E_{off}$  on  $R_G$**



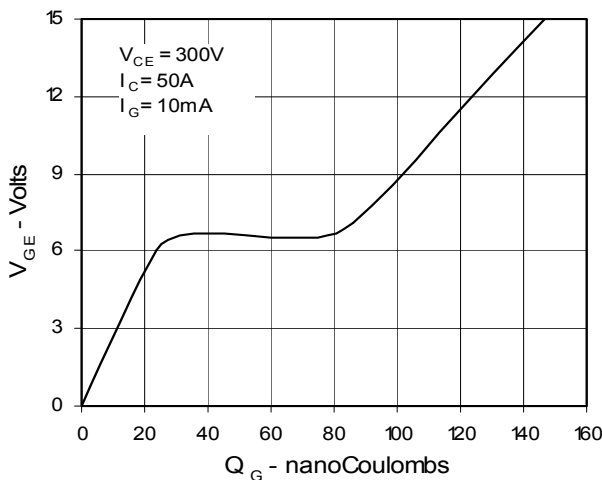
**Fig. 9. Dependence of  $E_{off}$  on  $I_C$**



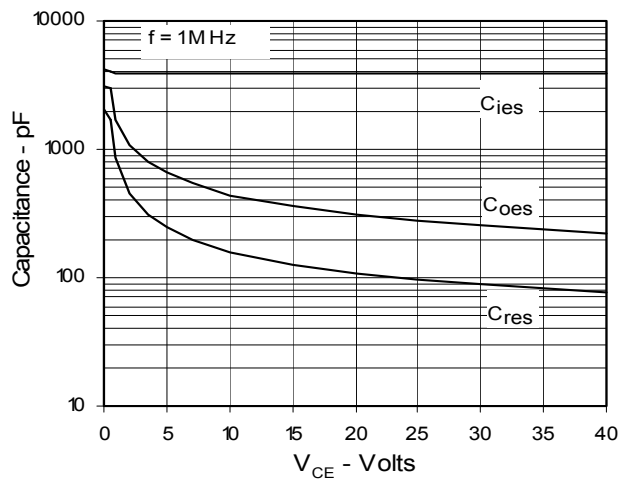
**Fig. 10. Dependence of  $E_{off}$  on Temperature**



**Fig. 11. Gate Charge**



**Fig. 12. Capacitance**



IXYS reserves the right to change limits, test conditions, and dimensions.

IXYS MOSFETs and IGBTs are covered by one or more of the following U.S. patents:

4,835,592 4,881,106 5,017,508 5,049,961 5,187,117 5,486,715 6,306,728B1 6,259,123B1 6,306,728B1  
4,850,072 4,931,844 5,034,796 5,063,307 5,237,481 5,381,025 6,404,065B1 6,162,665 6,534,343

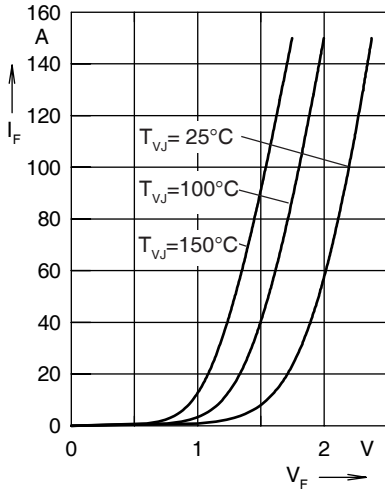


Fig. 12 Forward current  $I_F$  versus  $V_F$

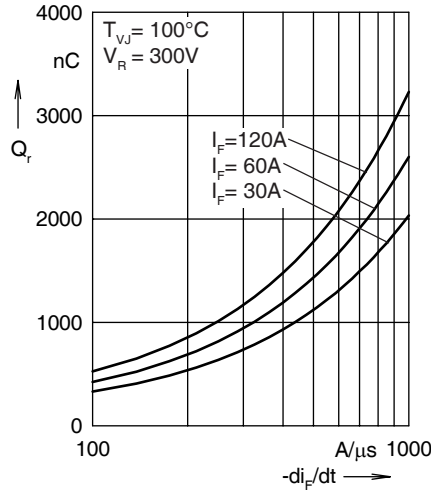


Fig. 13 Reverse recovery charge  $Q_r$  versus  $-di_F/dt$

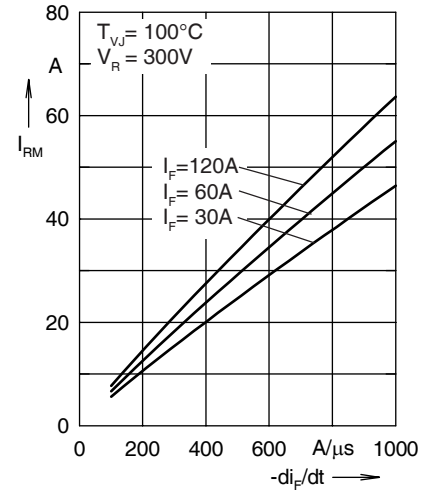


Fig. 14 Peak reverse current  $I_{RM}$  versus  $-di_F/dt$

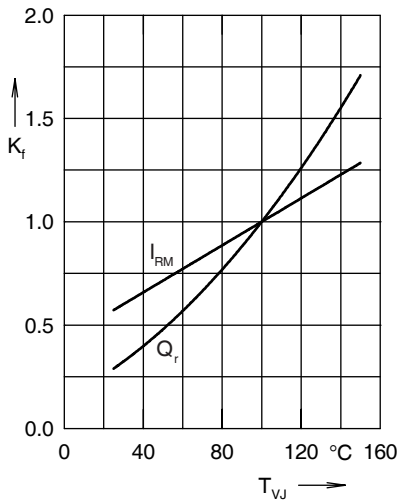


Fig. 15 Dynamic parameters  $Q_r$ ,  $I_{RM}$  versus  $T_{VJ}$

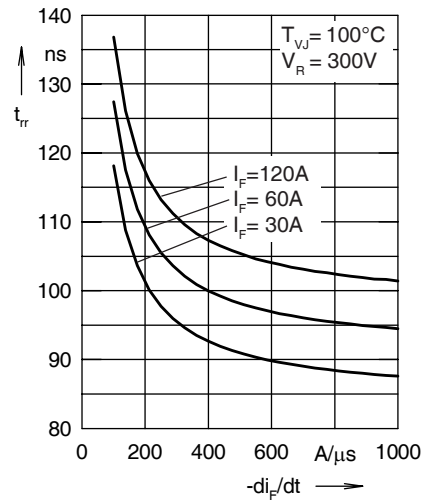


Fig. 16 Recovery time  $t_{rr}$  versus  $-di_F/dt$

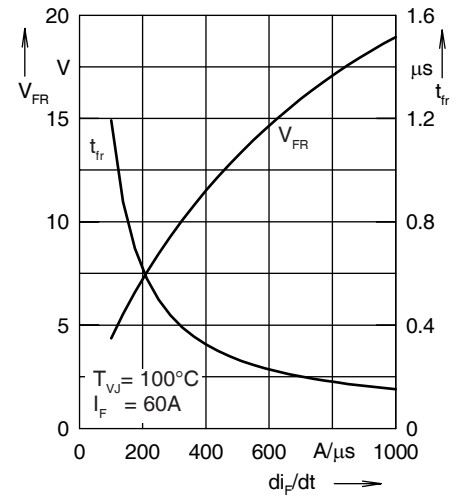


Fig. 17 Peak forward voltage  $V_{FR}$  and  $t_{rr}$  versus  $di_F/dt$

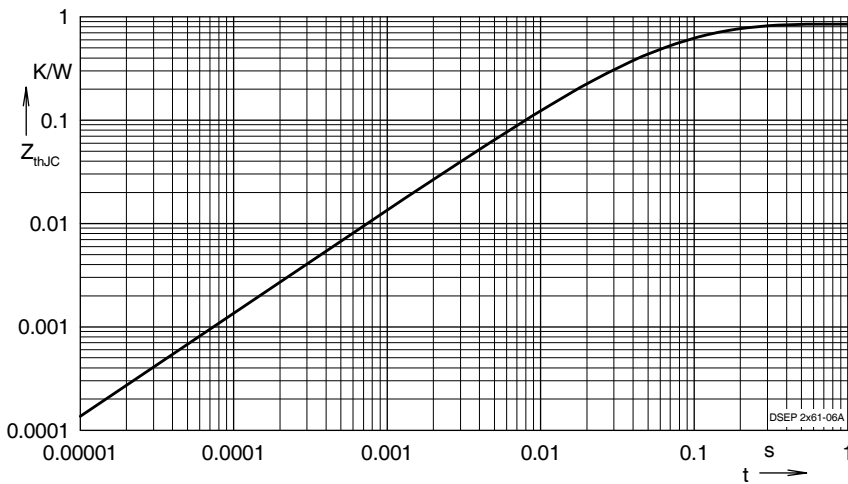


Fig. 18 Transient thermal resistance junction to case

Constants for  $Z_{thJC}$  calculation:

i	$R_{thi}$ (K/W)	$t_i$ (s)
1	0.3073	0.0055
2	0.3533	0.0092
3	0.0887	0.0007
4	0.1008	0.0399